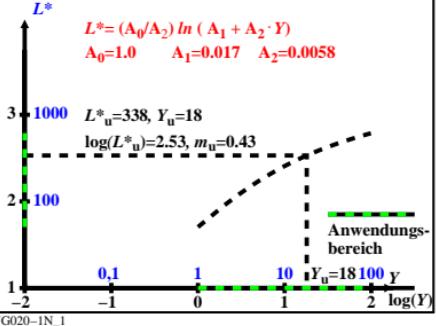
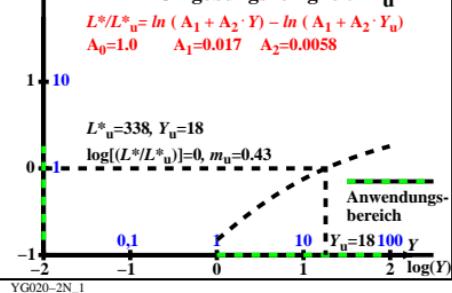


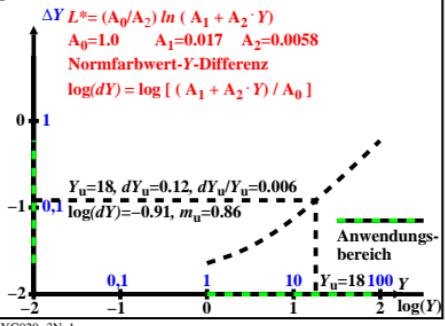
log (L*) LABJND Musterhelligkeit



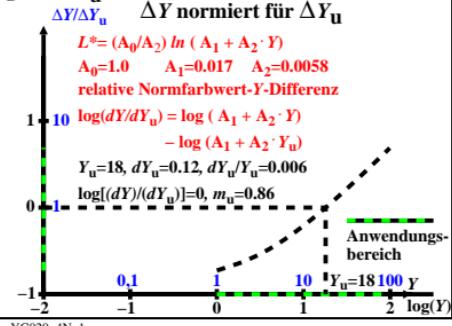
$\log(L^*/L^*_u)$ LABJND Musterhelligkeit L^* normiert für die Umgebungshelligkeit L^*_u



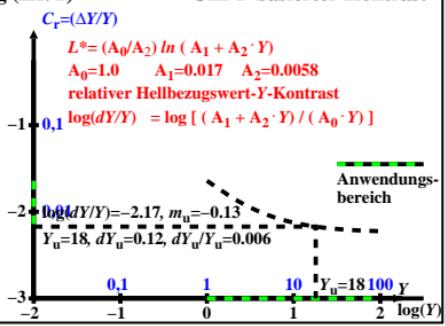
log ΔY CIE-Normfarbwertdifferenz ΔY



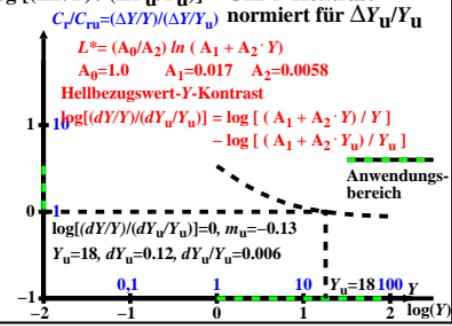
$\log(\Delta Y/\Delta Y_u)$ CIE-Normfarbwertdifferenz ΔY normiert für ΔY_u



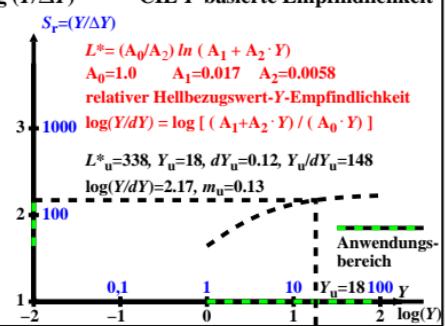
log $(\Delta Y/Y)$ CIE Y-basierter Kontrast



$\log [(\Delta Y/Y) / (\Delta Y_u/Y_u)]$ CIE Y-Kontrast



log $(Y/\Delta Y)$ CIE Y-basierte Empfindlichkeit



$\log [(Y/\Delta Y) / (Y_u/\Delta Y_u)]$ CIE Y-Empfindlichkeit

